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Clark I. Bright

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For: **TRANSPARENT CONDUCTIVE OXIDES FOR PLASTIC FLAT PANEL  
DISPLAYS**

CERTIFICATE OF MAILING

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Melanie Gover  
Signature: Melanie Gover

**PRELIMINARY AMENDMENT**

Commissioner for Patents  
Washington, DC 20231

Dear Sir:

Please enter the following preliminary amendment in the cited application.

**In the Claims:**

Please cancel claims 1-38.

Please add new claims 39-78

39. (New) A composite structure comprising:

a display structure further comprising:

a plastic substrate;

a first transparent layer of conductive barrier material deposited over the plastic substrate, the conductive barrier material being selected from the group consisting of a conductive oxide, a metal and a metal nitride; and

a first layer of organic polymer deposited contiguous to the conductive barrier material.

40. (New) A composite structure comprising:

a display structure further comprising:

a substrate;

a first layer of organic polymer deposited over the substrate; and

a first transparent layer of conductive barrier material deposited contiguous to the first organic polymer layer, the conductive barrier material being selected from the group consisting of a conductive oxide, a metal and a metal nitride.

41. (New) The composite structure of claim 39 further comprising a second layer of organic polymer deposited over the plastic substrate, in between the substrate and the conductive barrier layer.

42. (New) The composite structure of claim 40 further comprising a second layer of organic polymer deposited over the conductive barrier layer.

43. (New) The composite structure of claim 39 further comprising a second layer of conductive barrier material deposited over the first organic polymer layer, the second layer of conductive barrier material having the same composition as the first conductive barrier material.

44. (New) The composite structure of claim 39 further comprising multiple layers deposited over the first organic polymer layer, wherein said layers alternate between an additional conductive barrier material layer and a transparent layer selected from the group consisting of a layer of organic polymer, a layer of dielectric, a layer of metal and a layer of conductive oxide.

45. (New) The composite structure of claim 39 wherein the conductive barrier material is selected from the group consisting of aluminum, copper, silver, gold, a silver alloy and a gold alloy.

46. (New) The composite structure of claim 39 wherein the plastic substrate is selected from the group consisting of a polyester and a polyolefin.

47. (New) The composite structure of claim 39 wherein the conductive barrier material is tin doped indium oxide.

48. (New) The composite structure of claim 39 wherein the display structure further comprises a first transparent dielectric barrier layer comprised of a material selected from the group consisting of metal oxides and metal nitrides.

49. (New) The composite structure of claim 39 wherein the display structure further comprises multiple transparent layers that alternate between a layer of crosslinked organic monomer and a layer of conductive oxide.

50. (New) A process for fabricating a composite structure comprising:  
 providing a substrate;  
 depositing a first transparent layer of conductive barrier material over the substrate, the conductive barrier material being selected from the group consisting of a conductive oxide, a metal and a conductive metal nitride; and  
 depositing a first organic polymer layer contiguous to the first conductive barrier layer;  
 wherein said composite structure comprises a display structure.

51. (New) The process of claim 50 wherein the dielectric layer is deposited by a plasma assisted chemical vapor deposition process.

52. (New) The process of claim 50 further comprising depositing a second layer of organic polymer over the substrate, in between the substrate and the first layer of conductive barrier material.

53. (New) The process of claim 52 further comprising depositing a second layer of conductive barrier material over the first organic polymer layer, the second layer of conductive barrier material having the same composition as the first layer of conductive barrier material.

54. (New) The process of claim 52 further comprising depositing multiple layers over the first organic polymer layer, wherein said layers alternate between an additional conductive barrier material layer and a transparent layer selected from the group consisting of a layer of organic polymer, a layer of dielectric, a layer of metal and a layer of conductive oxide.

55. (New) The process of claim 50 further comprising depositing an additional layer of conductive barrier material over the first organic polymer layer, the additional layer of conductive barrier material having the same composition as the first layer of conductive barrier material.

56. (New) The process of claim 50 further comprising depositing multiple layers over the first organic polymer layer, wherein said layers alternate between an additional conductive barrier material layer and a transparent layer selected from the group consisting of a layer of organic polymer, a layer of dielectric, a layer of metal and a layer of conductive oxide.

57. (New) The process of claim 50 further comprising depositing, polymerizing and crosslinking an organic monomer in either a vacuum or a plasma to form the polymer layer.

58. (New) The process of claim 50 wherein the substrate is a plastic substrate, the process further comprising smoothing the plastic substrate by depositing a polymer over the substrate by a liquid coating method.

59. (New) The process of claim 50 wherein the first conductive barrier layer has an inner surface in contact with the substrate and an outer surface, further comprising depositing the polymer layer over the outer surface of the first conductive barrier layer before the outer surface of the first conductive barrier layer contacts another surface.

60. (New) The process of claim 50 further comprising depositing a transparent layer of a first dielectric barrier material comprised of a material selected from the group consisting of metal oxides and metal nitrides.

61. (New) The process of claim 50 wherein the conductive oxide is made by a first step comprising thermal evaporation, electron beam evaporation or sputtering of a metal followed by a second step comprising converting the metal to an oxide by exposing the metal to an oxygen containing plasma.

62. (New) The process of claim 50 wherein the conductive barrier layer is a conductive oxide layer deposited by a plasma assisted chemical vapor deposition process.

63. (New) The process of claim 50 wherein the conductive barrier layer is a metal layer deposited by either vacuum metallizing or sputtering.

64. (New) The process of claim 50 wherein the conductive barrier layer is a conductive oxide layer deposited by sputtering.

65. (New) The process of claim 64 wherein the sputtering deposition of the conductive oxide layer is carried out in a plasma comprising hydrogen gas.

66. (New) The composite structure of claim 39 wherein the conductive barrier material is a conductive oxide containing indium.

67. (New) The composite structure of claim 39 further comprising one or more additional layers of conductive barrier material deposited over the plastic substrate, the additional layers of conductive barrier material having a composition different from that of the first layer of conductive barrier material.

68. (New) The composite structure of claim 48 wherein the metal oxide is at least one metal oxide selected from the group consisting of an oxide of silicon, an oxide of titanium and an oxide of aluminum.

69. (New) The composite structure of claim 41 further comprising multiple transparent layers that alternate between a layer comprising crosslinked organic polymer and a layer comprising a conductive oxide.

70. (New) The process for forming the composite structure of claim 50 wherein the metal oxide is made by thermal evaporation, electron beam evaporation or sputtering of a metal in the presence of oxygen.

71. (New) The process for forming the composite structure of claim 50 wherein the metal nitride is made by thermal evaporation, electron beam evaporation or sputtering of a metal in the presence of nitrogen.

72. (New) The process for forming the composite structure of claim 53 wherein the dielectric layer is deposited by sputtering.

73. (New) The composite structure of claim 1 wherein a display medium is between two dyads each comprising a layer of organic polymer material contiguous to a layer of conductive barrier material.

74. (New) The composite structure of claim 73 further comprising one or more additional dyad, each additional dyad comprising an additional conductive barrier material layer and a transparent layer selected from the group consisting of a layer of organic polymer, a layer of dielectric, a layer of metal and a layer of conductive oxide.

75. (New) The composite structure of claim 40 wherein a display medium is between two dyads each comprising a layer of organic polymer material contiguous to a layer of conductive barrier material.

76. (New) The composite structure of claim 75 further comprising one or more additional dyad, each additional dyad comprising an additional conductive barrier material layer and a transparent layer selected from the group consisting of a layer of organic polymer, a layer of dielectric, a layer of metal and a layer of conductive oxide.

77. (New) The process for fabricating a composite structure of claim 50 wherein a display medium is placed between two dyads each comprising a layer of organic polymer material contiguous to a layer of conductive barrier material.

78. (New) The process of claim 77 further comprising depositing one or more additional dyad, each additional dyad comprising an additional conductive barrier material layer and a transparent layer selected from the group consisting of a layer of organic polymer, a layer of dielectric, a layer of metal and a layer of conductive oxide.

### REMARKS

Claims 1-38 have been cancelled. New claims 39-78 have been added.

Support for the newly added claims may be found in the Second Substitute Specification. Specific details are listed in the Table below.

New Claim	Original Claim	Support
39-65		Original claims 1-38
66		p. 12, lines 10-15
67		p. 4 lines 11-16
68		p. 4, lines 2-3 and p.14, line 22-23
69		p. 9, lines 33-35
70		p. 13, lines 13-16
71		p. 13, lines 13-16 and lines 23-29
72		p. 4, lines 23-24
73		Figure 1
74		p. 5, lines 32-35
75		Figure 1
76		p. 9, lines 8-23
77		Figure 1
78		p. 5, lines 32-35

Examination and consideration of the application is requested.

Registration Number 41,793	Telephone Number 651/736-4632
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Respectfully submitted,

By

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## TRANSPARENT CONDUCTIVE OXIDES FOR PLASTIC FLAT PANEL DISPLAYS

## 5 CROSS-REFERENCE TO RELATED APPLICATIONS

This application claims the benefit of U.S. Provisional Application No. 60/106,871, filed November 2, 1998. Further, this application incorporates by reference the content of the following: U.S. Patent No. 5,440,446, issued August 8, 1995, U.S. Patent No. 5,725,909, issued March 10, 1998, U.S. Patent Application No. 08/706,180, filed August 30, 1996, and U.S. Patent Application No. 08/741,609, filed October 31, 1996.

## FIELD OF THE INVENTION

This invention relates to composite substrates for flat panel displays (FPD), packaging materials and light sources (electro luminescence lamps) comprising a plastic substrate having thin film barrier and conductive layers, in particular, multiple thin alternating layers of metallic film, transparent conductive oxide (TCO), metal nitride, and organic polymers deposited over the plastic substrate.

## 20 BACKGROUND OF THE INVENTION

The use of portable electronic devices incorporating flat panel displays is prevalent and increasing rapidly. Because of the portable nature of these devices, it is desired to minimize both the size and weight and maximize durability. The display portion of the device is generally larger and denser as compared to the rest of the device, and is manufactured on glass substrates. Accordingly, a smaller, lighter and more durable portable electronic device is most effectively achieved with a smaller, lighter and shatterproof electronic device display.

Despite being lightweight, plastic has not been considered a viable substrate material to be used for the manufacture of flat panel displays for multiple reasons. Most importantly, flat panel displays fabricated with plastic substrates tend to fail prematurely due to degradation of display medium (display matrix) and/or metallic electrodes. In particular, the metallic electrodes and the display medium which is often positioned between the electrodes, become degraded when atmospheric oxygen and water vapor permeate the substrate and chemically degrade the active portion of the display matrix which is generally comprised of liquid crystals and/or light emitting devices. In addition,

common optical quality plastic substrates, e.g. polyethylene terephthalate (PET), have limited thermal properties. In particular, there is a limited temperature range that allows useful optical quality (e.g. clarity, transparency, and uniform index of refraction) to be maintained, while maintaining the substrate's mechanical strength and properties.

#### SUMMARY OF THE INVENTION

The present invention is directed to the fabrication of flat panel displays on lightweight, flexible, plastic substrates. Because plastic substrates for FPDs are flexible, smaller and lighter than glass substrates, the electronic device with the plastic FPD is more portable, space-efficient and lightweight. In addition, electroluminescent and organic light emitting devices fabricated on flexible polymeric substrates in a coating process have lower manufacturing costs than those with glass substrates, and improved ruggedness.

A display medium of the flat panel display is sandwiched between two electrode layers. At least one of the electrodes is transparent for viewing of the display. The display medium is protected from oxidative or moisture degradation. In the present invention, at least one layer, having both barrier characteristics and the ability to function as an electrode, is deposited over the substrate. In particular, the layer has both low oxygen and water vapor permeability, and a low enough resistivity to function as an electrode for the display. For lower permeability and/or higher conductivity, multiple alternating layers of barrier materials and conductive materials are applied. In an alternative embodiment, the conductive layers (e.g. transparent conductive oxide layers) are in direct electrical contact. The barrier material includes at least one of an organic polymer, a transparent dielectric, a transparent metal nitride and/or a transparent conductive oxide. The conductive material includes at least one of a thin transparent conductive oxide, a thin transparent metallic film and/or a metal nitride.

Using a smoothing base coat layer over the plastic substrate imparts good optical quality throughout the substrate layers and provides a pristine surface for nucleation of the deposited barrier or conductive layer, e.g. TCO. The pristine surface smooths over any surface roughness of the plastic substrate, thereby adding to the FPD lifetime and optical quality. Additionally, a hardcoat layer is applied over the substrate in lieu of or in addition to the smoothing basecoat layer.

The smoothing basecoat and hardcoat layers may be applied by one of many well known non-vacuum liquid coating processes, e.g. preferably by Gravure, or fabricated through a polymer multilayer (PML) coating process. Related desirable coating processes are disclosed in U.S. Patents 5,547,508, 5,395,644, 5,260,095, U.S. Patent Application Number 08/939,594, filed September 29, 1997, entitled "*Plasma enhanced chemical deposition with low vapor pressure compounds*" herein incorporated by reference, *Thin Film Processes II*, chapters II-2, 4, 5, and IV-1, edited by John L. Vossen and Wermer Kern, Academic Press, 1991, ISBN 0-12-728251-3, and *Deposition Technologies for Films and Coatings, Developments and Applications*, Rointan F. Bunshah et al, Chapters 5, 6, 8 and 9, Noyes Publications, 1982, ISBN 0-8155-0906-5.

The terms PML and PML process as used in this application are generic and mean any form of a PML process, including Plasma PML processes (PPML processes) and liquid PML processes (LML processes). The basic vacuum evaporation PML process is used to deposit organic monomers over the plastic substrate. The organic monomer is then polymerized in-situ by electron beam, a plasma process, or UV radiation.

The PML process is compatible with physical vapor deposition processes for layers such as TCO layers. Both processes are carried out in combined sequences within a properly designed single vacuum chamber. However, often multiple vacuum chambers are used, for example, if a substrate is hardcoated previously.

The PML deposited organic polymer layer is used to produce substrate surface smoothing and improve barrier coatings in the multilayer structure. The benefit of a smooth substrate surface is that there is a clean surface for adhesion, nucleation, and growth of a deposited barrier or conductive layer, e.g. a TCO. Additionally, a PML deposited organic polymer layer provides protection of an underlying barrier layer in order to minimize holes or other defects in the layer so that there is low permeability.

Neither a single layer barrier coating with a metal oxide layer such as thin film dielectric coatings of alumina or silica or other certain metal oxides, nor a plastic flat panel display with a thick metallic film layer having an optical density of greater than 2.0 renders low enough permeability for the processing and manufacture of plastic flat panel displays with acceptable lifetimes. Even where a single thick layer or multiple thin layers of dielectrics, metals or the combination thereof are used, the improvement in

performance is minimal. In order to provide barrier properties sufficient for optical quality plastic flat panel displays, a transparent dielectric barrier, such as  $\text{SiO}_{2-x}$  or  $\text{Al}_2\text{O}_{3-y}$ , is deposited over a plastic substrate. When dielectric layers are combined with PML deposited organic polymer layers, outstanding barrier properties are achieved on flexible plastic substrates. Alternatively to the dielectric layer, a barrier coating of ITO (called "indium tin oxide", which is actually "Tin doped indium oxide," a mixture of indium oxide and tin oxide) or another TCO barrier is deposited over the substrate. In yet another alternative embodiment, both TCO barrier layers and PML processed organic polymer layers are deposited over the plastic substrate. Moreover, in yet another alternative, both TCO barrier layers with PML processed organic polymer layers and the transparent dielectric barrier layers are deposited over the plastic or polymeric substrate. Multilayer structures of such organic and inorganic layers deposited over a plastic substrate exhibit significantly improved barrier properties as compared to inorganic, organic, or metallic layers alone.

In an embodiment, a PML processed top coat polymer layer is applied before the previously deposited layer contacts a surface, such as a roller, thereby protecting the previously deposited layer. The PML processed top coat greatly enhances the exclusion of moisture (water vapor) and atmospheric gases that chemically degrade the display medium and decrease the device performance, even though the polymer topcoat is not, itself, a good barrier material.

Metal oxide dielectric barriers have previously been deposited by evaporation, sputtering, and chemical vapor deposition processes onto glass substrates. However, for achieving metal oxide thin films with bulk material-like properties on glass substrates, a high temperature deposition method is used, which would melt the plastic substrate, thereby negatively impacting the mechanical properties of the plastic substrate. In the present invention, the PML family of processes used for depositing an organic dielectric does not require such high temperatures and therefore does not significantly alter the mechanical properties of the plastic substrate. However, organic polymer layers alone do not provide substantial barrier properties, particularly against water vapor.

When TCOs are deposited at low temperatures to accommodate the thermal and mechanical limits of the substrate, for example, by magnetron sputtering, electron-beam evaporation or plasma enhanced chemical vapor deposition (PECVD), the subsequent TCO coatings have less than bulk conductivity, i.e. low overall levels of conductivity.

TCO films with a larger thickness deposited through these methods achieve acceptable conductive levels for portable electronic devices. However, these thick films of TCO are subject to cracking, crazing and, in some instances, delamination from the substrate, especially when they are processed by a heat treatment step or a coating process involving mechanical rollers (e.g. web coating). Accordingly, the TCO coating is deposited in a series of thin, separated layers, yet still maintains high conductive levels. Multiple thin layers of TCO avoid the problems associated with thicker layers, and advantageously are electrically connected in parallel to provide adequate electrical performance characteristics.

The thin layers of TCO are preferably deposited in combination with layers from the PML process, which leads to improved optical, electrical and mechanical performance. In particular, the polymer layers separate the TCO layers. Superior surface properties (low surface roughness, and high optical quality), barrier properties (low vapor permeability) and mechanical properties result when TCO coatings are deposited by magnetron sputtering on a plastic substrate in combination with the PML process.

Preferably, moderate annealing temperature conditions, with respect to substrate limits, are used for TCO (including ITO, "tin doped indium oxide") deposition because high temperature conditions result in melting of the plastic, and low temperature conditions yields ITO layers with undesirable high resistivity. (The resistivity of ITO is a function of the oxygen and tin content, as well as the deposition conditions, such as temperature). A low resistivity for the ITO layers is desired. The resistivity of ITO decreases with a thicker TCO layer. But as discussed previously, thick TCO layers are prone to cracking or crazing. Multiple thin layers of TCO, as described in the present invention, will not crack and will yield a lower resistivity. Moreover, the surface resistivity of a thin film of TCO in multiple layers is low for a given total film thickness, due to its improved microstructure.

In a first embodiment of the present invention, a polymer smoothing coating is deposited over the substrate. The smoothing coating is applied by a PML process or liquid coating. A TCO, metal nitride, or metal layer is then deposited over the smoothing layer. Additionally, multiple alternating layers of a protective polymer layer and an additional TCO, metal nitride, or metal layer is deposited. Preferably, the alternating layers are of the same material, e.g. TCO/polymer/TCO, etc.

In a second embodiment, multiple alternating layers of polymer layers and metal oxide or metal nitride are deposited over the substrate or a polymer smoothing coating layer. A TCO layer is then deposited over the top of multiple alternating layers. These multiple alternating layers together with the TCO have adequate barrier and conductivity characteristics.

In a third embodiment, a substrate is coated with a TCO layer, a metal coating, and another TCO layer. This three layer configuration is called "optically enhanced metal," or an induced transmission filter and has similar characteristics as and is substitutable for a single TCO layer. With the optically enhanced metal good conductivity, optical transmission and barrier properties are achieved. A similar structure using metal nitrides substituted for the metal coating or the TCO layer, or one or more metal oxide layers substituted for one or more TCO layers, functions equivalently to the optically enhanced metal. For example, a further embodiment is comprised of a TCO layer, a conductive metal nitride layer and another TCO layer. Alternatively, the structure is a silicon nitride layer, a metal layer and another metal nitride layer.

In a fourth embodiment, a substrate is alternatively coated with an inorganic layer (such as TCO, metal nitride, or dielectric metal oxides), and polymer layers to provide both barrier and conductive properties.

#### BRIEF DESCRIPTION OF THE DRAWINGS

The aspects of the present invention described above in summary and below in more detail as well as various advantageous aspects will become appreciated as the same becomes better understood with reference to the specification, claims and drawings wherein:

FIG. 1 is a cross-sectional view of a composite substrate for a flat panel display (FPD) of the present invention;

FIG. 2 is a cross-sectional view of another embodiment of conductive barrier layer 3 of FIG. 1;

FIG. 3 is a cross-sectional view of another embodiment of conductive barrier layer 3 of FIG. 1;

FIG. 4 is a cross-sectional view of another embodiment of conductive barrier layer 3;

FIG. 5 is a cross-sectional view of another embodiment of conductive barrier layer 3 of FIG. 1;

FIG. 6 is a cross-sectional view of an embodiment of a conductive barrier layer; FIG. 7 is a cross-sectional view of an embodiment of conductive barrier layers of FIG. 1;

FIG. 8 is a cross-sectional view of an embodiment of conductive barrier layers of FIG. 1;

FIG. 9 is a cross-sectional view of an embodiment of conductive barrier layers of FIG. 1;

FIG. 10 is a cross-sectional view of an embodiment of conductive barrier layers of FIG. 1;

FIG. 11 is a cross-sectional view of an embodiment of conductive barrier layers of FIG. 1;

FIG. 12 is a cross-sectional view of an embodiment of conductive barrier layers;

FIG. 13 is a schematic illustration of a coating apparatus for forming the conductive barrier layer of FIG. 1;

FIG. 14a is a schematic illustration of a laminating process for the FPD of FIG.

1;

FIG. 14b is a cross-sectional view of the FPD before undergoing a bonding process;

FIG. 14c is a cross-sectional view of the FPD after undergoing a bonding process;

FIG. 15 is a chart showing water vapor permeability of an ITO film deposited on a polyethylene terephthalate (PET) substrate versus ITO film sheet resistance;

FIG. 16 is a chart showing water vapor permeability of ITO film deposited on a PET substrate versus ITO film thickness;

FIG. 17 is a chart showing oxygen permeability of ITO film deposited on a PET substrate versus ITO film thickness;

FIG. 18 is a chart showing oxygen permeability of ITO film deposited on a PET substrate versus ITO film sheet resistance;

FIG. 19 is a chart showing transmittance and reflectance spectra (for an ITO layer over a silver film layer over an ITO layer over a PET substrate at a sheet resistance of 14 Ohms/Square) versus wavelength;

FIG. 20 is a chart showing transmittance and reflectance spectra (for an ITO layer over a PET substrate at a sheet resistance of 29 Ohms/Square) versus wavelength;

FIG. 21 is a chart showing transmittance and reflectance spectra (for an ITO layer over a PET substrate at a sheet resistance of 57 Ohms/Square) versus wavelength;

FIG. 22 is a chart showing transmittance and reflectance spectra (for an ITO layer over a PET substrate at a sheet resistance of 65 Ohms/Square) versus wavelength; and

FIG. 23 is a chart showing transmittance and reflectance spectra (for an ITO layer over a PET substrate at a sheet resistance of 347 Ohms/Square) versus wavelength.

#### DETAILED DESCRIPTION OF THE INVENTION

A flat panel display (FPD) 1, of the present invention as shown in FIG. 1, employs at least one lightweight, plastic substrate 38 for fabricating FPDs. In one embodiment, the plastic is flexible. In another embodiment, the substrate used in the flat panel display is glass. In an alternative embodiment, there are two plastic substrates used to construct the FPD. In between two substrates of the flat panel display are at least two electrodes. At least one of the electrodes is transparent for viewing of the display. A display medium 2 for the flat panel display is usually positioned between the two electrodes. The display medium, as well as some electrode material, are protected from oxidative degradation and reaction with or incorporation of moisture.

The displays are fabricated using plastic substrates such as various polyolefins, e.g. polypropylene (PP), various polyesters, e.g. polyethylene terephthalate (PET), polymethylmethacrylate (PMMA) and other polymers such as polyethylene naphthalate (PEN), polyethersulphone (PES), polycarbonate (PC), polyetherimide (PEI), polyarylate (PAR), polyimide (PI), and polymers with trade names ARTON® (Japanese Synthetic Rubber Co., Tokyo, Japan) and AVATREL™ (B.F. Goodrich, Brecksville, Ohio). See Appendix A for deposition temperature capabilities of the particular plastic substrate.

In the present invention, at least one layer, a conductive barrier layer 3 has both barrier characteristics (to protect the display medium and/or the metal electrode from

oxidative degradation and reaction with or incorporation of moisture) and the ability to function as an electrode. The conductive barrier layer is deposited over the substrate to form a composite substrate, as shown in FIG. 6. In particular, layer 3 has both low oxygen and moisture (water vapor) permeability, and a low enough resistivity to function as an electrode for the display.

As shown in the general embodiments of FIGs. 2 through 5, conductive barrier layer 3 comprises at least one sublayer 3<sup>1</sup> deposited over the substrate, for instance a single ITO layer. In an embodiment, at least one pair of sublayers, a dyad, of a polymer layer 24 and a layer of TCO 22, metal 12, metal nitride 14 or metal oxide 16, is deposited over the substrate. Fig. 2 illustrates the sublayer having a dyad of metal 12 and metal oxide 16. Fig. 3 illustrates the sublayer having a dyad of metal nitride 14 and metal oxide 16. Fig. 4 illustrates the sublayer having a dyad of dielectric 17 and TCO 22. Fig. 5 illustrates the TCO layer 22 deposited over the dielectric layer 17 which is deposited over the polymer layer 24. The sublayers 3<sup>1</sup> deposited on either side of the pairs illustrated in Figs. 2-4 are, for example, a single ITO layer, additional dyads of the same materials, and/or a polymer coating. In an exemplary embodiment, multiple alternating sublayer pairs, comprised of the same materials as the original sublayer pair, are deposited over the substrate or over the previously deposited sublayer. In another embodiment the multiple alternating sublayer pairs deposited over the previously deposited sublayer comprise different sublayer materials than the previously deposited sublayer.

There are a myriad of possibilities for materials comprising the sublayers of the conductive barrier layer. FIGs. 2-5 illustrate generally only some of the more preferred embodiments of sublayer 3<sup>1</sup> materials for conductive barrier layer 3, while FIGs. 7-12 illustrate particularly the more preferred embodiments for the conductive barrier layer.

In one embodiment shown in Fig. 9, for example, a base coating 20 is deposited over the substrate 38. The base coating is a polymer smoothing coating applied by a PML process and/or an organic hardcoat. The base coating can be deposited by a non-vacuum liquid coating process (to render a hardcoated PET) or applied by a PML process. When a hardcoat is deposited, the plastic substrate is rendered abrasion resistant. A TCO layer 22 (or metal layer 12) is then deposited over the base coat. In another embodiment, multiple alternating layers of a protective polymer layer 24 and at least one TCO layer 22 (or metal layer 12) are additionally deposited (see FIG. 9).

Preferably, the alternating layers additionally deposited are of the same material, e.g. TCO/polymer/TCO, etc. Alternatively, there is no base coat 20 for the embodiment of alternating layers of polymer/TCO/polymer (not shown). In another embodiment, also shown in FIG. 9, a metal conductor or reflector 12 overlays the top polymer layer 24.

In the embodiment shown in FIG. 7, a substrate is coated with a TCO layer, a metal coating, and another TCO layer. This three layer configuration is called an "optically enhanced metal," or "induced transmission filter" and has characteristics similar to a single TCO layer, and is also substitutable for a single TCO layer. With the optically enhanced metal, good conductivity, transmission and barrier properties are achieved. In a preferred embodiment, deposited on the three layers is polymer layer 24 (see FIG. 8). The polymer layer 24 may be alternating with the optically enhanced metal (not shown). Alternatively, base coat 20 is deposited over the substrate as shown in FIG. 7. Additionally or alternatively, another dyad (a metal and TCO pair) is deposited over the top TCO layer and/or an additional polymer layer 24 (a polymer overcoat) is deposited over the previously deposited dyad (see FIG. 8). In another alternative, a thick metal layer 12 is deposited over the polymer overcoat layer, as also shown in FIG. 8. Alternatively, the metal nitride layer 14 is substituted for one or more of the metal layers in the above described embodiments, for example, see FIGs. 10 and 11.

In still another embodiment, the substrate is alternatively coated with an inorganic layer (such as the TCO layer or the dielectric metal oxide layer), and polymer layers to provide both barrier and conductive properties.

FIG. 12 illustrates metal layer 12 sandwiched between two metal nitride layers 14. Alternatively, additional dyads (metal and metal nitride pair) are deposited over the metal nitride layer. Further embodiments of this dyad pair are similar to the TCO/ metal dyad pair embodiments of FIGs. 7-8, i.e. the TCO layers of FIGs. 7-8 are replaced by one or more metal nitride layers.

In another alternative embodiment, the dielectric layer replaces one or more TCO layers in the above described embodiments (see generally FIGs. 4 and 5). As shown in FIG. 5, multiple alternating layers of dielectric 17 and polymer layers 24 are deposited over the substrate 38. The number of multiple alternating layers (or dyads) vary, and is represented here by 3<sup>1</sup>, sublayers of the conductive barrier layer 3. A TCO layer 22 (or metal layer 12) is then deposited over the top of multiple alternating layers. These multiple alternating layers together with the TCO have adequate barrier and conductivity

characteristics as described in more detail below.

Each TCO layer 22 of the above embodiments is a single TCO layer.  
5 Alternatively, the TCO layers in the Figures described above represents the thickness of two TCO layers from adjacent layers of "optically enhanced metal" of FIG. 8 or the metal nitride alternative of FIG. 11.

Preferably, the metal layers that are in the alternating dyad pairs or in between the TCO, metal nitride, or dielectric layers, are thin. The metal layers that are adjacent  
10 the "display medium," i.e. overlaying the dyad layers, or on the substrate, have a greater thickness than the sandwiched metal layers.

Sublayer 3<sup>1</sup> materials that provide transparent barrier properties are thin transparent metal oxides 16, and/or thin transparent metallic films 12, and/or thin metal nitrides 14, for example silicon nitride, and aluminum nitride. The polymer layer 24  
15 enhances barrier properties by reducing the number of holes and defects in the films upon which or under which, they are deposited. The metal oxide layer 16 comprises the dielectric layer 17 and/or the transparent conductive oxide layer 22. Thicknesses for the barrier layers are in the nanometer and angstrom range. Thicknesses for the PML deposited layers are in the micron and submicron range. For example, improved barrier  
20 coating occurs when a PML deposited organic polymer layer (a base coat), and/or a metal oxide layer is placed over the plastic substrate. See Table 2.

Sublayer 3<sup>1</sup> materials that provide conductive properties include the thin TCO layer 22, a thin transparent metallic film layer 12 (such as aluminum, silver, copper, gold, platinum, palladium, and alloys thereof), and the metal nitride layer 14 (such as  
25 transition metal nitrides, for example, titanium nitride, zirconium nitride, hafnium nitride, and nitrides of Group IIIA and IVA elements of the Periodic Table, e.g. gallium nitride). Thicknesses for the conductive layers are in the nanometer and angstrom range. Preferably the conductive film (TCO) is formed by multiple thin conductive layers (of TCO) separated by polymer layers. The conductive (TCO) layers are deposited with  
30 electrical contact to each other, so that a low resistivity is achieved. Consequently, the conductive film (TCO) functions as both the electrode and a barrier.

In the preferred embodiment, the PML processed base coat 20 is deposited over the substrate as shown in FIG. 9. The base coat produces substrate smoothing, and more importantly, in combination with other layers, the base coat has surprisingly  
35 effective vapor barrier enhancement properties because of the smoothing and

protection characteristics. The sublayers are preferably deposited in combination with the process illustrated in FIG. 13, as described below.

Using the smoothing base coat layer over the plastic substrate imparts good optical and barrier quality throughout the substrate layers and provides a pristine surface for nucleation of the deposited TCO electrode layer. The basecoat smooths over any surface roughness of the plastic substrate, thereby adding to the FPD lifetime and optical quality.

In an exemplary embodiment, one or more metal oxide layers are replaced with the TCO layer. When TCO coatings, including ITO ("Tin doped indium oxide"), cadmium oxides ( $\text{CdSn}_2\text{O}_4$ ,  $\text{CdGa}_2\text{O}_4$ ,  $\text{CdIn}_2\text{O}_4$ ,  $\text{CdSb}_2\text{O}_6$ ,  $\text{CdGeO}_4$ ), tin oxides (various alloys and dopants thereof), indium oxides ( $\text{In}_2\text{O}_3$ : Ga,  $\text{GaInO}_3$  (Sn, Ge),  $(\text{GaIn})_2\text{O}_3$ ), zinc oxides ( $\text{ZnO}(\text{Al})$ ,  $\text{ZnO}(\text{Ga})$ ,  $\text{ZnSnO}_3$ ,  $\text{Zn}_2\text{SnO}_4$ ,  $\text{Zn}_2\text{In}_2\text{O}_5$ ,  $\text{Zn}_3\text{In}_2\text{O}_6$ ), and/or magnesium oxides ( $\text{MgIn}_2\text{O}_4$ ,  $\text{MgIn}_2\text{O}_4 - \text{Zn}_2\text{In}_2\text{O}_5$ ) are deposited on the plastic substrate at a low temperature, they have an amorphous microstructure. For characteristics of the above TCO materials, see Appendix B. The amorphous structure and oxygen deficiency of the TCO theoretically allows the TCO coating to exhibit conductive properties and barrier properties similar to transparent dielectric barrier layers, such as nonstoichiometric types of silica or alumina. Also, because of the oxygen deficiency, and amorphous structure, the barrier layers gather the oxygen and keep the oxygen from passing through. Multiple thin layers of TCO function as both a transparent electrode and a transparent barrier layer. The benefit of using TCO alternating with metallic film layers, besides the beneficial barrier properties, is that all the layers of the structure are conductive, thus improving conductivity.

In the preferred embodiment, a suitable apparatus for coating the substrate with conductive and barrier layers is illustrated schematically in FIG. 13. All of the coating equipment is positioned in a vacuum chamber 36. A roll of polypropylene, polyester or other suitable plastic sheet is mounted on a pay-out reel 37. Plastic sheet 38 forming the substrate is wrapped around a first rotatable drum 39, and fed to a take-up reel 41. A roller 42 is employed, as appropriate, for guiding the sheet material from the payout reel to the drum and/or to the take-up reel.

A flash evaporator 43 is mounted in proximity to the drum at a first coating station. The flash evaporator deposits a layer or film of monomer, typically an acrylate, on the substrate sheet as it travels around the drum. After being coated with a

monomer, the substrate sheet passes a radiation station where the monomer is irradiated by a source 44 such as an electron gun or source of ultraviolet (UV) radiation. The UV radiation or electron bombardment of the film induces polymerization of the monomer.

The sheet then passes coating station 46 where a coating of TCO is preferably applied by magnetron sputtering. The sheet then passes another flash evaporator 47 where another layer of monomer is deposited over the TCO layer. The sheet then passes radiation station 48 and the monomer is polymerized. Depending on whether a layer of monomer is above or below the TCO layer, either evaporator 43 or 47 is used. Clearly, if the TCO layer is to be sandwiched between layers of polymer, both evaporators and their respective radiation sources are used. In addition to magnetron sputtering, the TCO layer is processed by one of thermal evaporation, chemical vapor deposition, plasma enhanced chemical vapor deposition, and electron beam evaporation. Chemical vapor deposition is a high temperature process, and is therefore the least desirable for use with plastic substrates but is acceptable for metal foil substrates.

In an alternative embodiment, a LML smoothing or hardcoat layer applicator 52 is mounted in proximity to the drum at a first coating station. The liquid smoothing applicator deposits a layer of monomer, e.g. acrylate, over the substrate. This layer of monomer is cured by irradiation from an ultraviolet or electron beam source 44 adjacent the drum (the positions of source 44 and applicator 52 are interchanged). Additionally, the sheet then passes coating station 46 where a coating of thin metal film, metal oxide, and/or metal nitride is applied by one of vacuum sputtering, vacuum metallizing, plasma assisted chemical vapor deposition, or electron beam evaporation. For example, silicon oxides is deposited by a plasma enhanced chemical vapor deposition process using a metal organic precursor and an oxidizing or inert carrier gas coating station 46 alternatively containing deposition sources.

The various layers described are deposited in several processes, in addition to vacuum coating techniques. For instance, the layers are deposited through nonvacuum (atmospheric) roll coating. Alternatively or additionally, the layers are deposited by an in line coating machine, whereby a conveyor belt runs the substrate to be coated past multiple coating stations. In a further alternative, the layers are deposited by an intermittent motion machine, that is either in a vacuum process or a nonvacuum

process. In yet another alternative, the layers are coated using a multitude of machines and/or processes. For instance, the plastic substrate is first coated through atmospheric  
5 roll coating with a cured polymer and subsequently coated by vacuum deposition, or liquid coated, such as Gravure coating.

For multiple layers of organic polymer coatings deposited in the PML process, take up reel 41, with the sheet wound thereon, functions as the pay out reel 37, and the process is repeated as desired by coating in both directions. For this alternative,  
10 additional curing stations are mounted on the opposite side of evaporators 43 or 47. The roll of sheet is removed from the vacuum system for use.

FIG. 14a illustrates a laminating process for the FPD where plastic substrates, hardcoating, and a display medium are bonded together, for example, with an adhesive and pressure, temperature or UV radiation. FIGs. 14b and 14c are cross-sectional  
15 schematic views of the FPD before and after undergoing the bonding process, respectively. The laminating process is one of the alternate methods for bonding the layers to construct the FPD. Because the layers of the present invention are thin, cracking, crazing, and delamination are avoided using processing methods of this type. FIGs. 14b and 14c illustrate schematically the flat panel display with an exterior  
20 protective overcoat 4 and the display medium 2. The display medium also may be liquid, or deposited over either substrate, or over a carrier film.

Transparent dielectric layers with good barrier properties and a high refractive index, such as metal oxides like titanium oxide or aluminum oxide, or metal nitrides such as silicon nitride or aluminum nitride, used in combination with thin, transparent metallic  
25 film layers provide a transparent conductive barrier coating. The metal oxide or metal nitride layers are deposited at specific thicknesses to optimize the optical performance (e.g. transmittance) of a particular display. Preferably, the thin metallic film layer is sandwiched in between layers of metal oxide or metal nitride. Multiple alternating layers of metal oxides or metal nitrides, with their barrier properties, and the highly conductive  
30 metallic film layers provide increased barrier performance and conductivity for a particular display medium.

The optical and electrical performance of transparent conductive oxide coatings are also improved by mildly heating the coated substrate during deposition or by post-annealing the coated substrate. As shown in the Experimental Results below,  
35 even though the PET substrate was heated to a moderate temperature of only 65°C,

the resistivity of the ITO was still low enough to effectively operate as an electrode, because of the multiple thin layers of ITO.

In an alternative embodiment, the thin conductive metal nitride layer is substituted for one or more thin metallic film layers, for example, for the metal layers in the "optically enhanced metal" (see Fig. 11). Metal oxide or TCO layers are utilized with the metal nitride layer for enhancing both the optical and electrical performance characteristics. Metal nitrides have good gas barrier properties. However, to achieve very low moisture (water vapor) and oxygen permeability, there is a minimum thickness of barrier material, e.g. the metal nitride layer. Because of the higher optical transparency silicon nitride thin films, for example, are attractive candidates for flexible FPD as barrier layers for atmospheric gases.

In another alternative embodiment, at least one of the metallic film layers in, for example, the "optically enhanced metal" is replaced with a polymer layer formed via the PML processes.

#### RESULTS OF CONDUCTED EXPERIMENTS

The plastic substrate for a flat panel display has a very low oxygen and water vapor permeability, a surface roughness much less than the barrier film thickness, a high Tg (the glass transition temperature) to allow a higher temperature and/or higher energy ITO deposition process, and a high transparency with low birefringence.

Defects in the coated layers limit the barrier properties. For instance, rough substrates, particulates, and roller contact, damage the coated layers. Rough substrates with thin film barriers are smoothed and prevented from damage by roller contact, with an organic basecoat and polymer top coat.

Multiple layers of TCO deposited on the substrate achieve lower surface resistivity than a single thick layer of TCO because the single layer cracks and/or crazes from stress. Further, the multiple TCO layers act as electrodes connected in parallel. Using a non-stoichiometric dielectric of a group including silicon oxides, aluminum oxides, and silicon nitrides, allows for the fabrication of efficient thin film barriers for flexible plastic films.

Measured data for films made of sputtered ITO exhibited exceptional barrier properties. The optical, electrical and barrier properties were measured for ITO sputter-deposited directly onto a PET substrate, and also measured with a PML acrylic

basecoat over the substrate before deposition of the ITO, in a roll-to-roll (web) coating process. See FIGs. 15-18, and the descriptions of these Figures below. The typical performance of a single ITO layer deposited on a basecoated PET substrate is 85%T (Transmittance) and .80 ohms/square. The ITO layer has a physical thickness of about 140 nm, for a one-half wave optical thickness, while the PET substrate has a thickness of about 0.007". For the single layer ITO film, oxygen permeability ranged from 0.005 to 0.05 oxygen cc/m<sup>2</sup>/day, while the water vapor permeability ranged from 0.005 to 0.05 g/m<sup>2</sup>/day.

FIG. 15 discloses a chart showing water vapor permeability of (1) ITO film deposited over the PET substrate, and (2) a PET substrate coated with "optically enhanced metal": an ITO film layer, a silver layer, and another ITO film layer, versus ITO film resistance. No smoothing base coat was applied to the substrate in either case. The ITO layer was DC sputter deposited onto the PET substrate. The deposited ITO film alone is reactively sputtered from a metal target in a web coater. The solid lines shown connect the midpoints of the range of permeability results at each measured resistance for the ITO film sheet. The chart shows that for the ITO film layer, the water vapor permeability dips to a minimal value of approximately 0.006 g/m<sup>2</sup> day at a resistance of about 60 ohms/square. The water vapor permeability reaches a maximum of approximately 0.21 g/m<sup>2</sup> day at a resistance of about 350 ohms/square. For the silver layer in between the ITO film layers, the approximate water vapor permeability range was 0.04 to 0.075 g/m<sup>2</sup> day for the sheet resistance at about 12 ohms/square.

FIG. 16 discloses a chart showing water vapor permeability of an (1) ITO film deposited over the PET substrate, and (2) a PET substrate coated with "optically enhanced metal," an ITO film layer, a silver layer, and another ITO film layer, versus ITO film sheet thickness. The parameters for the ITO layer alone is analyzed in the same manner as above. The chart shows that for the ITO film layer, the water vapor permeability dips to a minimal value of approximately 0.006 g/m<sup>2</sup> day at an ITO thickness of about 120 nm. The water vapor permeability reaches a maximum of approximately 0.21 g/m<sup>2</sup> day at an ITO thickness of about 40 nm. For the substrate with the sandwiched silver layer, the approximate water vapor permeability range was 0.04 to 0.075 g/m<sup>2</sup> day for a total ITO coating thickness of approximately 120 nm.

FIGs. 17 and 18 disclose charts showing oxygen permeability of ITO film deposited on a PET substrate versus ITO film thickness and versus sheet resistivity, respectively. FIG. 17 shows that the permeability dips to a minimal value of approximately 0.017 g/m<sup>2</sup> day at an ITO thickness of about 220 nm. The permeability reaches a maximum of approximately 0.9 cc/m<sup>2</sup> day at an ITO thickness of about 40 nm.

As shown in Table 1, alternating barrier layers of PML deposited organic polymers and dielectrics have permeation rates below the limits of the instruments, which is 0.005 g/m<sup>2</sup> day for Permatran-W 3/31, which is an instrument that measures water vapor transmission rates, and 0.005 cc/m<sup>2</sup> day for Ox-Tran 2/20, which is an instrument that measures oxygen transmission rates.

The transparent dielectric barrier layer or the single layer of TCO deposited on the substrate has suitable barrier properties for the plastic FPD. The preferable barrier properties vary by the type of display technology: liquid crystal display (LCD), organic light emitting display (OLED), or thin film electro luminescent displays (TFELD). The acceptable value of vapor permeation with plastic substrates for FPD depends on the sensitivity of the specific display technology utilized. For example, the LCD is much less sensitive to vapor permeation than the OLED or TFELD. For the LCD, maximum oxygen permeability is in the range of about 0.01 to 0.1 cc/m<sup>2</sup> day, while the maximum water vapor permeability is in the range of about 0.01 to 0.1 g/m<sup>2</sup> day. For both OLED and TFELD, permeabilities of  $\leq 0.001$  cc/m<sup>2</sup> day for oxygen, and  $\leq 0.001$  g/m<sup>2</sup> day for moisture (water vapor) are preferred.

A polymer OLED and a small molecule OLED describe the two basic technologies for the layer that emits light in the OLED. For polymer OLED's, the light emitting material is deposited by flow coating, spin coating, gravure coating, meniscus coating, curtain coating or any common liquid coating or printing techniques. The small molecule OLED is normally thermally evaporated in a vacuum, but may also be processed with nonvacuum coating methods. When the ITO layer is deposited by nonvacuum processes such as by screen printing, the process of the present invention is entirely nonvacuum. Alternatively, the process of the present invention takes place by both vacuum and nonvacuum methods. Preferably, the process takes place entirely in a vacuum to avoid contamination by particulates, moisture and oxygen. Superior barrier films and other films result from the cleaner vacuum process.

As shown in FIGs. 15 and 16, and described above, for the LCD as long as the

ITO sheet resistance is below about 250 Ohms/square, and the ITO film thickness is between about 75 and 225 nm, the water vapor permeability is within desirable limits for the LCD. As shown in FIG. 17, the oxygen permeability is within desirable limits for the LCD as long as the ITO film thickness is above about 85 nm and the sheet resistance is below about 150 Ohm/square. Because of the lower permeabilities preferred for the emissive displays (e.g. OLED and thin film electro luminescent displays), the barrier capability is enhanced by multilayer dielectric or TCO barriers in combination with PML processed polymer coatings (i.e. composite barrier layers of PML deposited organic polymer layers, dielectric layers and/or TCO layers).

Appendix D has two charts that illustrate water vapor and oxygen permeability versus ITO thickness. The measured results for semi-reactively and reactively sputtered ITO, as well as the differences between a single ITO layer and two ITO layers (with a polymer layer in between the two layers) made with a semi-reactive process, are illustrated and in tabular form. 'Semi-reactively' sputtered refers to films, DC magnetron sputtered from a ceramic target. The differences between the two processes are believed to be due to the specific process parameters, and not inherent to the process type. As shown, for the same total thickness deposited by the same reactive process, two ITO layers have higher conductivity and lower permeability as compared to the single ITO layer. Further, the two ITO layers have higher electrical performance, because the single ITO layer cracks and/or crazes.

The preferred thickness for the deposited layers is different for conductivity properties than for barrier properties. The thickness of the deposited film is related to the film's conductive and barrier properties. The critical thickness for barrier properties of these layers varies with the material and, to a lesser extent, how the layer is deposited. For ITO, the critical thickness is about 20 nanometers (or 200 angstroms), minimum. The lower thickness limits for some of the metal oxides which are typically used in packing applications is in about the 10 to 30 nanometer range. Generally, 5-10 nanometers is the minimum thickness for adequate barrier properties. Enhanced conductive properties result from film thicknesses in the range of about 20 nanometers to 300 nanometers. If the single layer film is thicker than that range, then the film starts cracking, and hence, loses conductivity and barrier properties. For maximizing single layer optical transmission, it is well known that certain optical thicknesses, e.g. one-half wave, of thin films are selected. The typical physical thickness is in the range of about

20 to 300 nanometers for ITO on a flexible substrate.

FIGs. 20-23 are charts showing transmittance and reflectance spectra versus wavelength for an ITO layer deposited over a PET substrate at a sheet resistance of 29 Ohms/Square, 57 Ohms/Square, 65 Ohms/Square, and 347 Ohms/Square, respectively. As shown, generally, for a range of the sheet resistance, the percentage of spectral transmittance and reflectance remains relatively constant. For example, at about a wavelength of 500 nm, the transmittance percentage is about 80% for resistance ranging from 29 ohms/square to 347 ohms/square. DC sputter deposited ITO on a hardcoated PET substrate exhibited a sheet resistivity of 46.9 Ohms/square, which is a volume resistivity of approximately  $5 \times 10^{-4}$  Ohm-cm, and a visible transmittance of about 84.7%. Generally, the transmittance increases (and the reflectance decreases) as the plasma wavelength increases. There is always a compromise between high optical transmittance and high conductivity.

In contrast to Figs. 20-23, in FIG. 19 the transmittance decreases and the reflectance increases at the higher wavelengths. FIG. 19 is a chart showing transmittance and reflectance spectra versus wavelength for a more preferred embodiment of the present invention. Fig. 19 shows the transmittance spectra for a PET substrate coated with layers of an ITO, silver film, and another ITO at a sheet resistance of 14 Ohms/Square.

Appendix E illustrates the Transmittance and Reflectance of semi-reactively sputtered ITO on a PET substrate for various thicknesses versus wavelength. The transmittance and reflectance of a substrate coated with a polymer layer and an ITO layer, a substrate with an ITO layer, and a substrate with two ITO layers (with a polymer layer in between the two ITO layers) are illustrated. Generally, transmittance and conductivity are inversely related. Improved optical performance is achieved by controlling the thickness and index of the polymer layers.

For a transparent electrode, conductivity specifications varies with display technology and addressing method. The surface resistivity for LCD's is about 50-300 Ohms/square, and for OLED's is about 10-100 Ohms/square. The corresponding visible transmittance for LCD's is about 90%, and for OLED's is about 80-85%. The thickness of the conductor layer is compatible with the vacuum web coating processing for the flexible plastic substrate.

Table 1 shows the test results for oxygen and water vapor transmission rates of

various samples of a PET substrate coated with a single ITO layer with different Ohms/square coatings and a substrate coated with an ITO layer, a metal layer, and another ITO layer. The test conditions were as follows: the temperature was at 23°C/73.4°F. On each side of the barrier for the oxygen transmission rate tests, the relative humidity was 0%. On one side of the barrier for the water vapor transmission rate tests, the relative humidity was 100%, but the other side of the barrier had a relative humidity of 0%.

The first eight samples of Table 1 are of a plastic substrate coated with a single ITO film layer, each with different nominal ITO thickness and sheet resistances. For example, the '25-1' is the first sample with a sheet resistance of 25 Ohm/square; whereas '25-2' is the second sample from the same lot. The last two samples are of a substrate coated with an ITO layer, a metal coating, and another ITO layer, with a nominal sheet resistance of 10 Ohm/square. This 3 layer configuration is the "optically enhanced metal," or "induced transmission filter," and has similar characteristics to a single TCO layer. With the optically enhanced metal, good conductivity, transmission and barrier properties are achieved. Preferably the ITO layers, which antireflect the metal, each have a thickness of about 30-60 nanometers. In several instances, the samples were tested two times. For example, the second column for the 25 and 60 Ohms/square samples reflects the results of the second test.

Although the present invention has been described and is illustrated with respect to various embodiments thereof, it is to be understood that it is not to be so limited, because changes and modifications may be made therein which are within the full intended scope of this invention as hereinafter claimed. In particular, the structure disclosed in the present invention for flat panel displays is schematic for LCD and other display technologies, such as polymer organic light emitting diode (POLED), small molecule organic light emitting diode (OLED) displays, and thin film electro-luminescent.

Table 1

Sample	Water Vapor Transmission Rate (g/m <sup>2</sup> day)		Oxygen Transmission Rate (cc/m <sup>2</sup> day)	
25-1	0.026	<0.005 <sup>1</sup>	0.017	0.087
25-2	0.097	<0.005 <sup>1</sup>	0.584	0.257
60-1	0.042		0.059	0.071
60-2	0.050		0.204	0.090
60-3	0.007		<0.005 <sup>2</sup>	
60-4	<0.005 <sup>1</sup>		0.014	
300-1	0.243		0.861	
300-2	0.232		0.864	
M-10-1	0.076		0.035	
M-10-2	0.041		0.024	

<sup>1</sup> The actual water vapor transmission rate was at least as low as the lower limit of the instrument, Permatran-W 3/31, 0.005 g/m<sup>2</sup> day.

<sup>2</sup> The actual oxygen transmission rate was at least as low as the lower limit of the instrument, Ox-Tran 2/20, 0.005 cc/m<sup>2</sup> day.

Table 2 compares permeation rates for different coatings, including multiple dyad (an acrylate/oxide pair) layers on the polyethylene terephthalate (PET) substrate, and coatings on oriented polypropylene (OPP) substrates. As shown, a single dyad on a substrate has high oxygen and moisture permeation resistance. In some instances, two oxygen transmission rate tests were conducted, and the results were shown in a second column. Footnote <sup>1</sup> denotes the typical permeation rate for the PET substrate.

**Table 2**

Sample	Water Vapor Transmission Rate (g/m <sup>2</sup> day)	Oxygen Transmission Rate (cc/m <sup>2</sup> day)	
2 mil PET	30.5, 272 <sup>1</sup> per micron film thickness	5.3, 1550 <sup>1</sup> per micron film thickness	
Food packaging - target values (PET/oxide)	1.55	1.5	
2 mil PET/single dyad (23°C)	<0.0078	0.03	
2 mil PET/ seven dyads (23°C)	<0.0078	<0.016	
7 mil PET/ hardcoat (23°C)	7.6	-	
7 mil PET/ hardcoat/ single dyad (38°C)	<0.0078, 90% Relative Humidity (RH), 100% O <sub>2</sub>	0.2682, 100% RH	0.6061, 100% RH
7 mil PET/ hardcoat/ single dyad/ ITO (38°C)	<0.0078, 90% RH, 100% O <sub>2</sub>	0.0098, 100% RH	0.0128, 100% RH
PET/oxide	0.7-1.5	0.15-0.9	
PET/Al	0.6	0.17	
OPP, copolymer, 1 mil	1800	1.3	
OPP/ oxide	17-546	0.08-0.4	
OPP/Al	20	0.11	

## TRANSPARENT CONDUCTIVE OXIDES FOR PLASTIC FLAT PANEL DISPLAYS

## 5 ABSTRACT

A lightweight, flexible, plastic substrate used to construct displays, including flat panel displays, to package materials and for electro luminescence lamps is coated with at least one layer, such that the substrate has desired barrier and electrode characteristics. The display medium of the flat panel display is protected from oxygen and moisture in order to avoid degradation with the coating. The layer with barrier and electrode characteristics has both a low enough resistance to function as an electrode for the display, and low oxygen and moisture permeability. For lower permeability and/or higher conductivity, multiple alternating layers of barrier materials and conductive materials are applied. The barrier material includes at least one of a thin metallic film, an organic polymer, a thin transparent dielectric, a thin transparent metal nitride, and a thin transparent conductive oxide. The conductive material includes at least one of a thin transparent conductive oxide, a thin transparent metallic film, and a thin transparent metal nitride. Preferably there is a Polymer Multi Layer (PML) processed base coat deposited over the substrate. The base coat produces substrate smoothing, and more importantly, in combination with another layer, the base coat improves vapor barrier properties. In the preferred embodiment, a PML processed top coat barrier layer is deposited before the coating contacts a surface, such as a roller. The PML processed top coat also excludes moisture (water vapor) and atmospheric gases that chemically degrade the device performance.

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